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| Notice of References Cited | Application/Control No. 09/735,429 | Applicant(s)/Patent Under Reexamination JAGADEESAN, RAMANATHAN T | |
| | Examiner Gregory B Sefcheck | Art Unit 2662 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------------|----------------|
| | A | US-2002/0145982 A1 | 10-2002 | Talpade et al. | 370/253 |
| | B | US-2002/0031126 | 03-2002 | Crichton et al. | 370/394 |
| | C | US-6,694,478 B1 | 02-2004 | Martinian et al. | 714/788 |
| | D | US-6,693,921 B1 | 02-2004 | Whitfield, Michael C. | 370/516 |
| | E | US-6,597,660 B1 | 07-2003 | Rueda et al. | 370/230.1 |
| | F | US-6,487,603 B1 | 11-2002 | Schuster et al. | 709/231 |
| | G | US-6,434,606 B1 | 08-2002 | Borella et al. | 709/214 |
| | H | US-6,370,120 B1 | 04-2002 | Hardy, William Christopher | 370/252 |
| | I | US-5,956,729 A | 09-1999 | Goetz et al. | 707/104.1 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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